

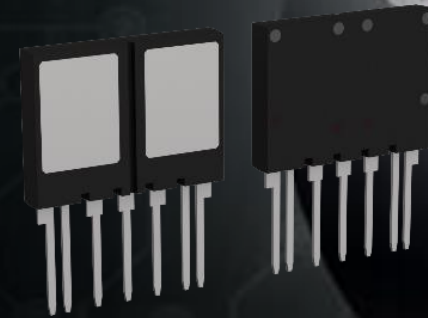


Electronics for the Future

DOT247 Built-in 4th Gen SiC MOSFET Technology

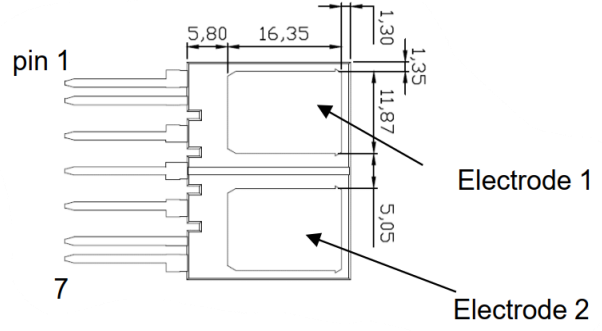
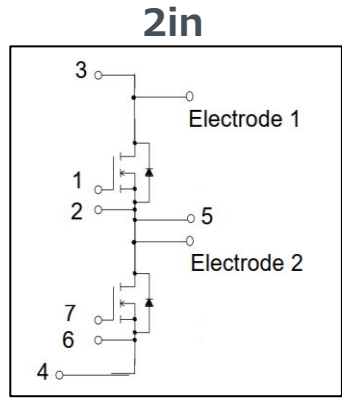
March 2023

ATSC
ROHM Semiconductor

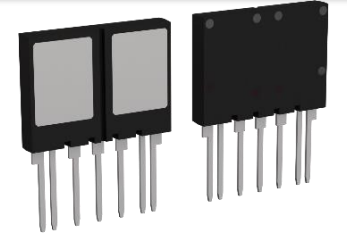
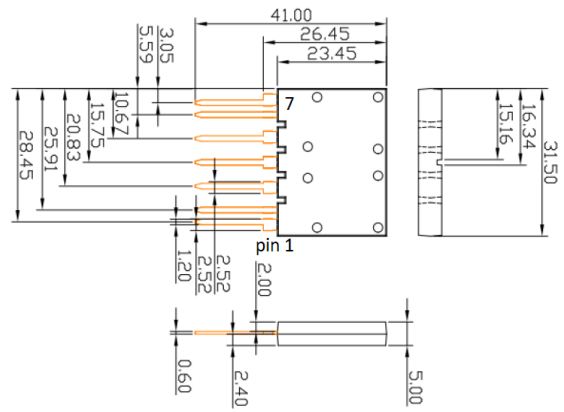


- Introduction of DOT-247
- Line-up and development schedule
- Thermic advantages
- Power cycle capability
- Assembling method
- PCB size reduction application example

Schematic



Dimensions



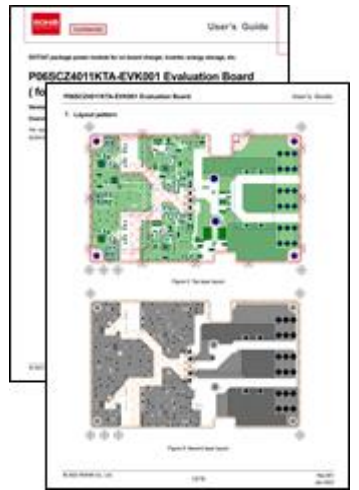
This item does NOT have isolation function inside the package

Benefits DOT247

- Improved package for thermal dissipation
- Improved reliability
- Higher power density
- Low Ls realizes high frequency drive
- Wide Line-up
- Automotive-grade with lower Rds_on

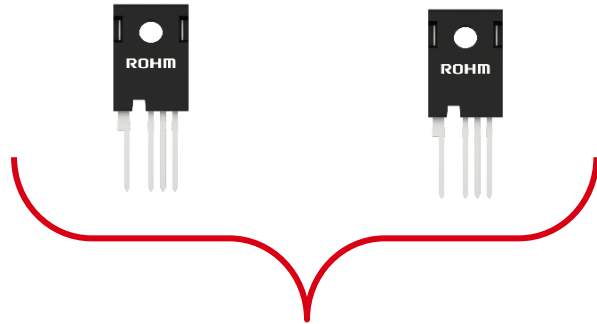
Evaluation Kit

Evaluation Kit on Request



DOT247 Lineup and development schedule information

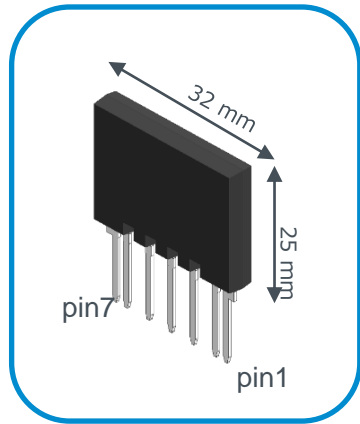
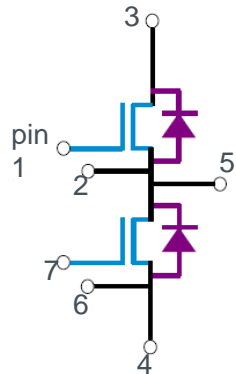
Discrete TO247- 4L




◆ Sample Available

◆ MP: Middle of 2023

Power Discrete
DOT 247

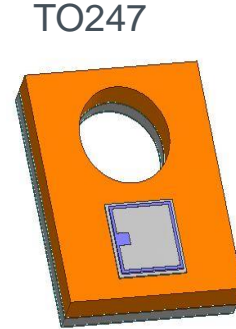
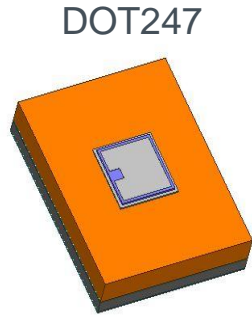


Product lineup

Module type	V _{dss}	R _{on}	Product No.(tentative)	MOS	Topology
 *no-isolation	1200V	18mΩ	SCZ4018KTAHRC23	4G	Trench Half bridge
		11mΩ	SCZ4011KTAHRC23		
		6mΩ	SCZ4006KTAHRC23		
	750V	13mΩ	SCZ4013DTAHRC23		
		8mΩ	SCZ4008DTAHRC23		
		4mΩ	SCZ4004DTAHRC23		

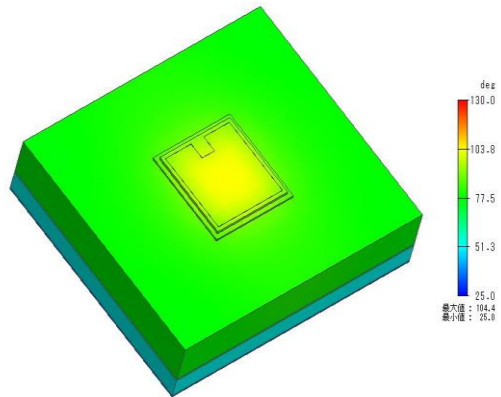
Thermal resistance comparing with TO247 package

Layer	Thermal conductivity (W/m/K)	Thickness (mm)
SiC	370	-
Solder	64	-
Cu Frame	364	-
Grease	1	0.1
AlN	170	1
Grease	1	0.1



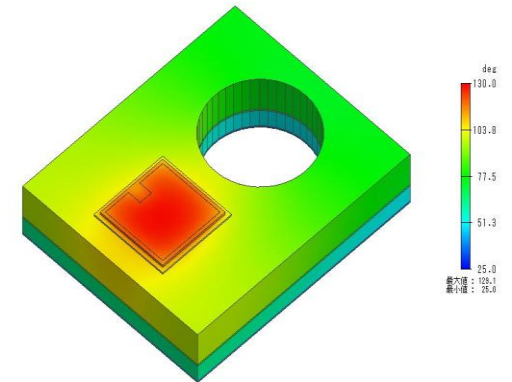
- ❑ The same thickness of each layer
- ❑ Input power (one chip) : 63.6W
- ❑ Heat sink temp $T_a = 25^\circ\text{C}$
- ❑ Heat transfer coefficient $5000\text{W/m}^2/\text{K}$

Layer	Thermal conductivity (W/m/K)	Thickness (mm)
SiC	370	-
Solder	24	-
Cu frame	364	-
Grease	1	0.1
AlN	170	1
Grease	1	0.1



	Rthj-c[K/W] $T_a=25^\circ\text{C}$	Rthj-a[K/W] $T_a=25^\circ\text{C}$
TO247-4L	0.34	1.04
DOT247	0.22	0.80

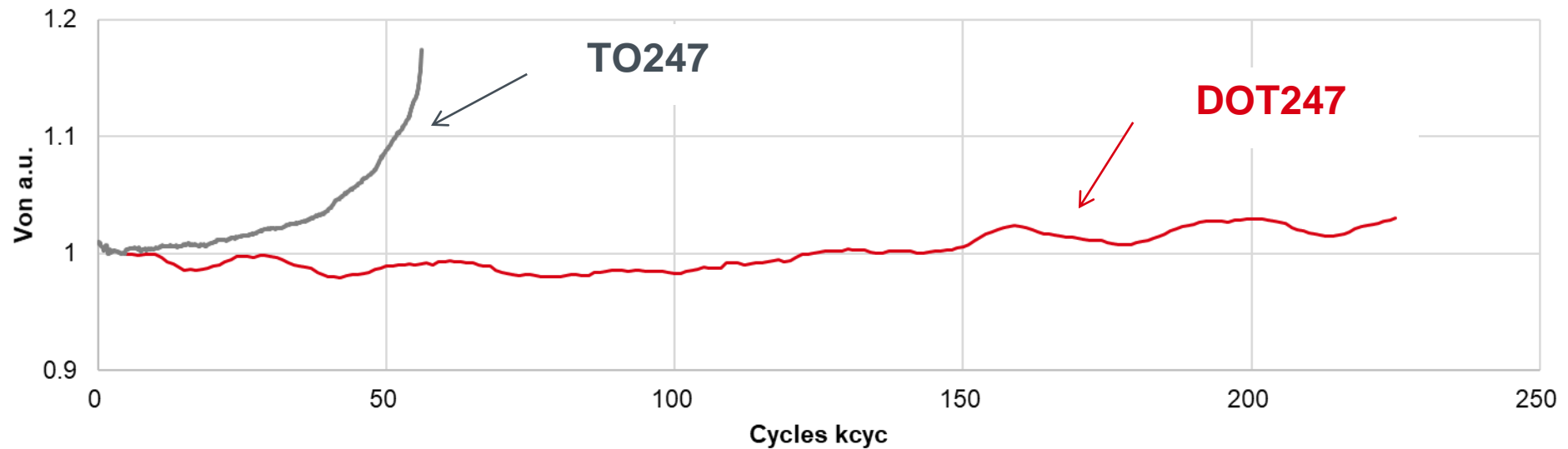
35% Down 23% Down



Power cycle capability

Durability of power cycling test comparing with TO247

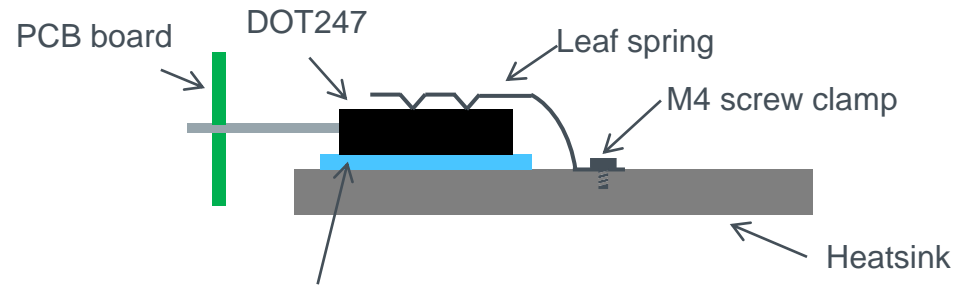
Parameter	Value
Testing equipment	Siemens T3STER PWT900A
t_on/t_off	2s/18s
Temperature swing	Tj=50°C~150°C
D.U.T cooling method	water



✓ Longer (~x4) PC lifetime compared to TO247 achieved by use of copper clips.

Mounting method (example)

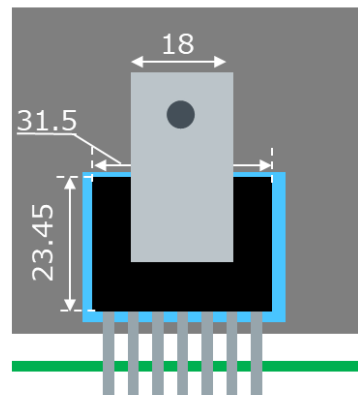
Side view



Ex.) Thermal sheet with insulation function

Top view

- Hold center of DOT247 by single leaf spring.



Reference; mounting of TO247

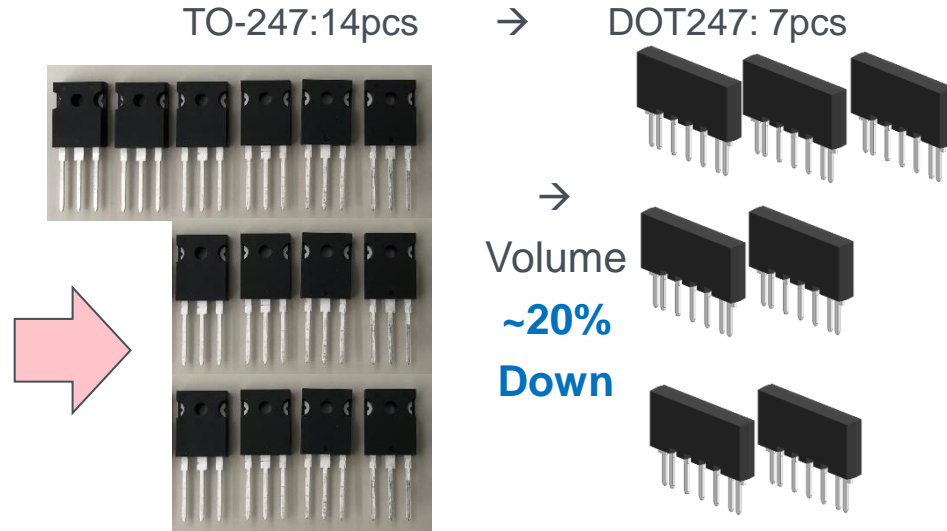
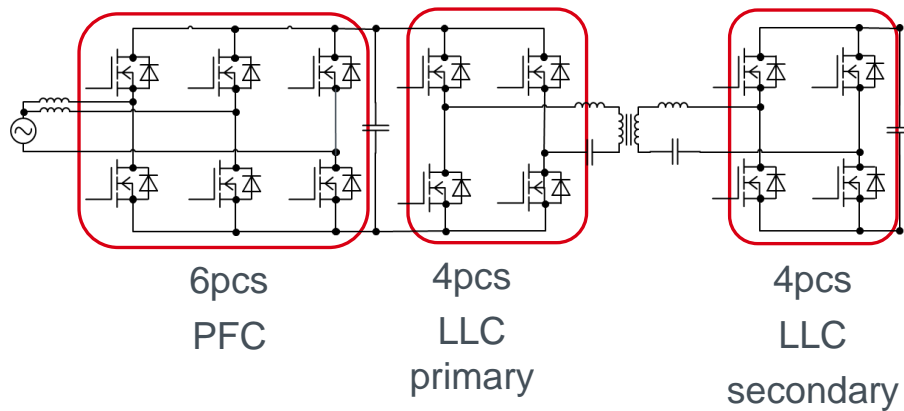


Leads are mounted on the board

- ✓ Insulation between DOT247 and heatsink is needed
- ✓ DOT247 is not compatible with reflow soldering

Contribution to Miniaturization

Bidirectional Charger topology



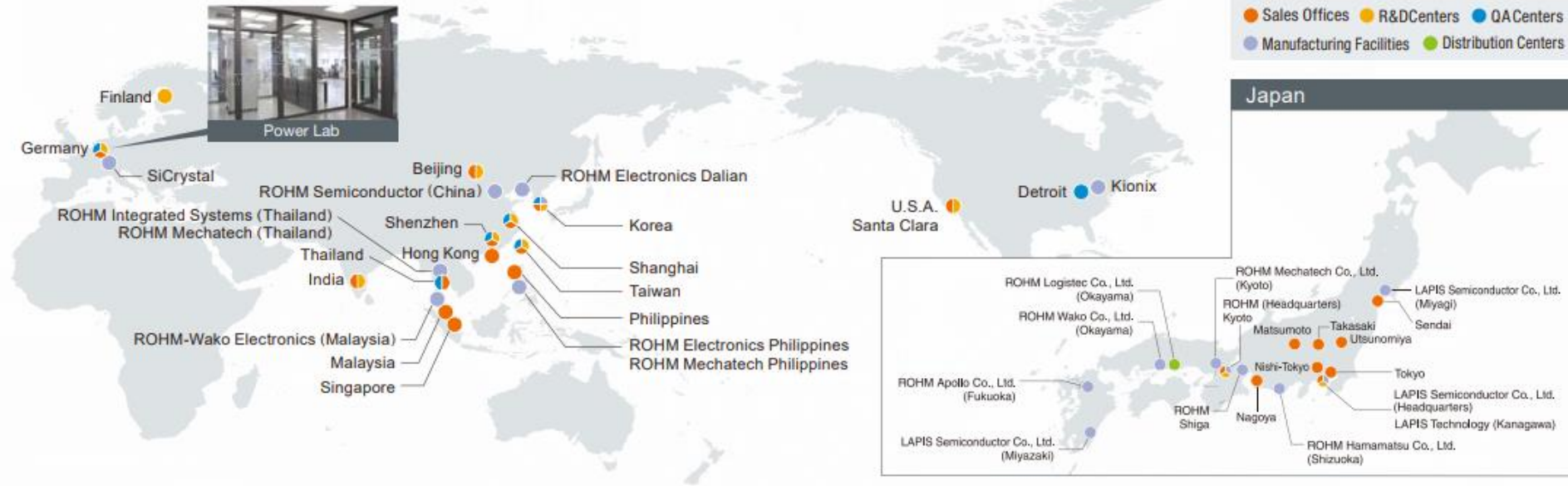
**By using DOT247 package versus TO247-4L could help to reduce overall Inverter size up to ~20%
Example design at ~22KW bidirectional DC-Wallbox**

Worldwide distributed high level support

Application-Level Support

ROHM's Support System

We provide global support for the integrated design of high-speed switching SiC devices and gate drivers that combine high accuracy with fast switching control.



SiC MOSFET Evaluation Board

PCB005P Rev.C

An evaluation board is offered that allows for easy evaluation of SiC devices

ROHM Solution Simulator

ROHM's web simulation tool enables complete circuit verification of power devices and driver ICs

ROHM Solution Simulator

Simulates SiC devices in environments closer to real-world applications, including gate drivers and peripheral circuits.

Electricity Cost Testing of EVs Based on the International WLTC Standard

Test Conditions: Driving Pattern: WLTC Class 3b, Assumed Vehicle: C-Segment EV
 Test Motor: Permanent magnet synchronous motor (100kW, 800V)
 Device: SiC vs IGBT (1,200V)

Inverter Efficiency Comparison: 4th Gen SiC MOSFET vs IGBT
 Inverter Efficiency Map

Significantly improved efficiency in the high torque and low rotational speed range

Expanded high efficiency area



Electronics for the Future

ROHM Semiconductor GmbH

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